

SKM460GM12M7



SEMITRANS 3

IGBT M7 Modules

SKM460GM12M7

Features*

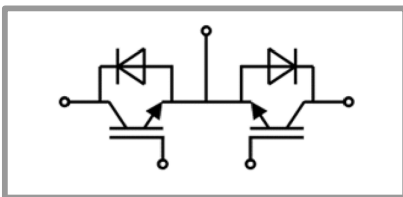
- $V_{CE(sat)}$ with positive temperature coefficient
- High overload capability
- Low loss high density IGBT's
- Fast & soft switching inverse CAL diodes
- Large clearance (10 mm) and creepage distances (20 mm)
- Insulated copper baseplate using DBC Technology (Direct Bonded Copper)
- UL recognized, file no. E63532

Typical Applications

- Matrix inverter
- Bidirectional switch

Remarks

- Max. case temperature limited to $T_C = T_S = 125\text{ °C}$
- Product reliability results are valid for $T_J = 150\text{ °C}$ (recommended $T_{J,op} = -40...+150\text{ °C}$)
- For storage and case temperature with TIM see document: "Technical Explanations Thermal Interface Materials"



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| Absolute Maximum Ratings | | | | |
|--------------------------|--|-----------------------|--------------------|--------------------|
| Symbol | Conditions | Values | Unit | |
| IGBT | | | | |
| V_{CES} | $T_J = 25\text{ °C}$ | 1200 | V | |
| I_C | $T_J = 175\text{ °C}$ | $T_C = 25\text{ °C}$ | 581 | A |
| | | $T_C = 80\text{ °C}$ | 442 | A |
| I_{Cnom} | | 460 | A | |
| I_{CRM} | | 920 | A | |
| V_{GES} | | -20 ... 20 | V | |
| t_{psc} | $V_{CC} = 800\text{ V}$ $V_{GE} \leq 15\text{ V}$ $V_{CES} \leq 1200\text{ V}$ | $T_J = 150\text{ °C}$ | 8 | μs |
| T_J | | | -40 ... 175 | $^{\circ}\text{C}$ |
| Inverse diode | | | | |
| V_{RRM} | $T_J = 25\text{ °C}$ | 1200 | V | |
| I_F | $T_J = 175\text{ °C}$ | $T_C = 25\text{ °C}$ | 588 | A |
| | | $T_C = 80\text{ °C}$ | 439 | A |
| I_{FRM} | | 1000 | A | |
| I_{FSM} | $t_p = 10\text{ ms}$, sin 180°, $T_J = 25\text{ °C}$ | 2304 | A | |
| T_J | | | -40 ... 175 | $^{\circ}\text{C}$ |
| Module | | | | |
| $I_{t(RMS)}$ | | 500 | A | |
| T_{stg} | module without TIM | -40 ... 125 | $^{\circ}\text{C}$ | |
| V_{isol} | AC sinus 50 Hz, $t = 1\text{ min}$ | 4000 | V | |

| Characteristics | | | | | |
|-----------------|--|-----------------------|-------|-------|------------|
| Symbol | Conditions | min. | typ. | max. | Unit |
| IGBT | | | | | |
| $V_{CE(sat)}$ | $I_C = 460\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel | $T_J = 25\text{ °C}$ | 1.54 | 1.93 | V |
| | | $T_J = 150\text{ °C}$ | 1.81 | | V |
| V_{CE0} | chipelevel | $T_J = 25\text{ °C}$ | 0.86 | 0.96 | V |
| | | $T_J = 150\text{ °C}$ | 0.75 | | V |
| r_{CE} | $V_{GE} = 15\text{ V}$ chipelevel | $T_J = 25\text{ °C}$ | 1.48 | 2.1 | m Ω |
| | | $T_J = 150\text{ °C}$ | 2.3 | | m Ω |
| $V_{GE(th)}$ | $V_{CE} = 10\text{ V}$, $I_C = 46\text{ mA}$ | 5.4 | 6 | 6.6 | V |
| I_{CES} | $V_{GE} = 0\text{ V}$, $V_{CE} = 1200\text{ V}$, $T_J = 25\text{ °C}$ | | | 4.6 | mA |
| C_{ies} | $V_{CE} = 10\text{ V}$ $V_{GE} = 0\text{ V}$ | $f = 1\text{ MHz}$ | 88.0 | | nF |
| C_{oes} | | $f = 1\text{ MHz}$ | 2.76 | | nF |
| C_{res} | | $f = 1\text{ MHz}$ | 1.08 | | nF |
| Q_G | $V_{GE} = -8\text{ V} \dots +15\text{ V}$ | | 4100 | | nC |
| R_{Gint} | $T_J = 25\text{ °C}$ | | 1.15 | | Ω |
| $t_{d(on)}$ | $V_{CC} = 600\text{ V}$ $I_C = 460\text{ A}$ $V_{GE} = +15/-15\text{ V}$ | $T_J = 150\text{ °C}$ | 330 | | ns |
| t_r | | $T_J = 150\text{ °C}$ | 83 | | ns |
| E_{on} | $R_{G on} = 1\text{ }\Omega$ $R_{G off} = 1\text{ }\Omega$ | $T_J = 150\text{ °C}$ | 60 | | mJ |
| $t_{d(off)}$ | | $T_J = 150\text{ °C}$ | 400 | | ns |
| t_f | $di/dt_{on} = 6500\text{ A}/\mu\text{s}$ $di/dt_{off} = 4350\text{ A}/\mu\text{s}$ $dv/dt = 5900\text{ A}/\mu\text{s}$ | $T_J = 150\text{ °C}$ | 87 | | ns |
| E_{off} | | $T_J = 150\text{ °C}$ | 49 | | mJ |
| $R_{th(j-c)}$ | per IGBT | | | 0.086 | K/W |
| $R_{th(c-s)}$ | per IGBT, P12 (reference) | | 0.032 | | K/W |
| $R_{th(c-s)}$ | per IGBT, HP-PCM | | 0.023 | | K/W |

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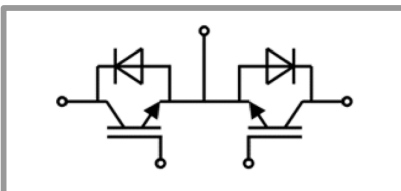
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|----------------------|--|-----------------------|------|--------|-------|------|
| Symbol | Conditions | | min. | typ. | max. | Unit |
| Inverse diode | | | | | | |
| $V_F = V_{EC}$ | $I_F = 460\text{ A}$ $V_{GE} = 0\text{ V}$ chipelevel | $T_J = 25\text{ °C}$ | | 2.05 | 2.36 | V |
| | | $T_J = 150\text{ °C}$ | | 1.96 | | V |
| V_{F0} | chipelevel | $T_J = 25\text{ °C}$ | | 1.30 | 1.50 | V |
| | | $T_J = 150\text{ °C}$ | | 0.90 | | V |
| r_F | chipelevel | $T_J = 25\text{ °C}$ | | 1.64 | 1.88 | mΩ |
| | | $T_J = 150\text{ °C}$ | | 2.3 | | mΩ |
| I_{RRM} | $V_{CC} = 600\text{ V}$ | $T_J = 150\text{ °C}$ | | 430 | | A |
| Q_{rr} | $I_F = 460\text{ A}$ $V_{GE} = -15\text{ V}$ | $T_J = 150\text{ °C}$ | | 77 | | μC |
| E_{rr} | $di/dt_{off} = 6430\text{ A/μs}$ | $T_J = 150\text{ °C}$ | | 33 | | mJ |
| $R_{th(j-c)}$ | per diode | | | | 0.104 | K/W |
| $R_{th(c-s)}$ | per diode, P12 (reference) | | | 0.034 | | K/W |
| $R_{th(c-s)}$ | per diode, HP-PCM | | | 0.024 | | K/W |
| Module | | | | | | |
| L_{CE} | | | | 31 | | nH |
| R_{CC+EE} | measured per switch | $T_J = 25\text{ °C}$ | | 0.55 | | mΩ |
| | | $T_J = 150\text{ °C}$ | | 0.85 | | mΩ |
| $R_{th(c-s)1}$ | calculated without thermal coupling, P12 (reference) | | | 0.0085 | | K/W |
| $R_{th(c-s)2}$ | including thermal coupling, T_s underneath module, P12 (reference) | | | 0.013 | | K/W |
| $R_{th(c-s)2}$ | including thermal coupling, T_s underneath module, HP-PCM | | | 0.0074 | | K/W |
| M_s | to heat sink M6 | | 3 | | 5 | Nm |
| M_t | to terminal M6 | | 2.5 | | 5 | Nm |
| | | | | - | | Nm |
| w | | | | | 325 | g |

